Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/721,363	TAKEMURA ET AL.	
Examiner	Art Unit	
David Mis	2817	

	SEAR	CHED	-
Class	Subclass	Date	Examiner
331	68,	5/19/2005	DM.
	108D,		
	116R,		
	116FE,		
	116M,		
	158-159,		
	187		
361	760,		
	767-771		

INT	TERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
as	above	5/19/2005	DM
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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